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SINCE 1975

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INSTRUCTIONS

MODEL AVX-D-2 DELAY GENERATOR

S.N.:

WARRANTY

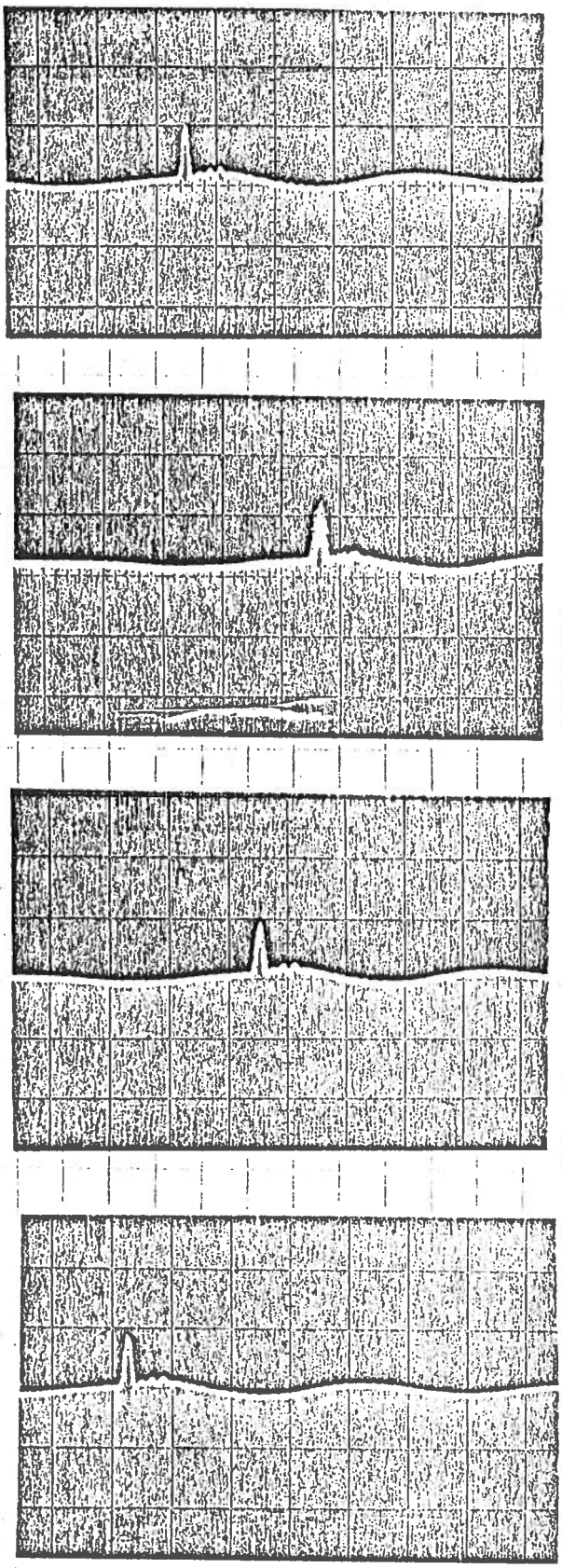
Avtech Electrosystems Ltd. warrants products of its manufacture to be free from defects in material and workmanship under conditions of normal use. If, within one year after delivery to the original owner, and after prepaid return by the original owner, this Avtech product is found to be defective, Avtech shall at its option repair or replace said defective item. This warranty does not apply to units which have been dissembled, modified or subjected to conditions exceeding the applicable specifications or ratings. This warranty is the extent of the obligation or liability assumed by Avtech with respect to this product and no other warranty or guarantee is either expressed or implied.

SPECIFICATIONS

MODEL AVX-D-2

Model designation:	AVX-D-2
Delay range:	100 nsec to 10 usec Low range: 90 nsec to approx. 700 nsec Med. range: 650 nsec to 2.90 usec High range: 2.90 usec to 10 usec 10 turn DL pot control determines delay within each range
PRF range:	0 to 1 MHz Note that at given PRF, max delay can not exceed one half of period of PRF
Jitter:	±30 psec at min DELAY ±60 psec at max DELAY (confirmed using AVH-S-1 130 psec impulse generators & sampling scope display)
Input PW:	50 to 500 nsec
Output PW:	200 to 300 nsec
Trig. PW:	Equals input PW
Prop delay, IN to TRIG port:	≤10 nsec
Signal amplitudes:	TTL levels Outputs will drive 50 ohm loads
Power requirements:	+15V DC 100 mA
Connectors:	SMA
Chassis:	As AVX-D but with addition of range switch

SLIDER TEST RESULTS



a) AUH-3-1 OUTPUT NO DELAY, Ch NO AUX-D-2 UNITS

b) 9 msec DELAY

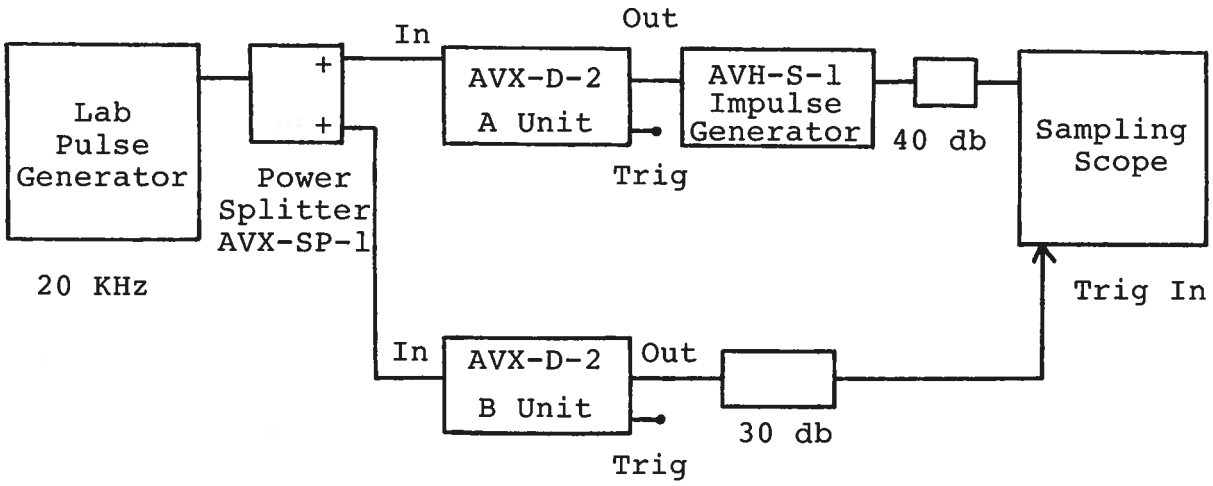
c) 2 msec DELAY.

d) 0.4 msec DELAY

RL PHOTO
1.0 msec / DIV
10 VOLTS / DIV.
20 KHz.

MODEL AVX-D-2

JITTER AND DELAY TEST ARRANGEMENT



1) A worse-case jitter test of the AVX-D-2 unit was conducted using the above arrangement. The use of two delay generators serves to:

   a) Aggravate the jitter since the resultant jitter is the consequence of two units.
   b) Allow triggering of the sampling scope with long delays (eg. 10 usec) on the AVX-D-2 units.

2) The delays of the A and B units should be such that the time base of the sampling scope is triggered slightly ahead (eg. 20-100 nsec) of the application of the impulse to the vertical amplifier.

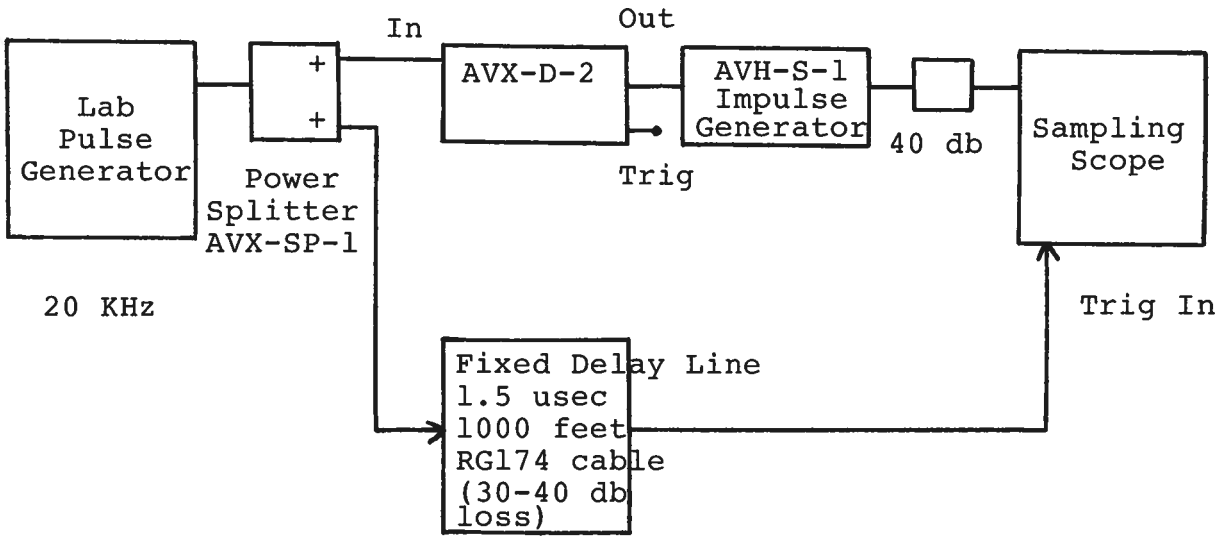
3) The photos on the following sheet illustrates the AVH-S-1 output waveform for the following three cases:

   a) No delay, ie. AVX-D-2 A and B units removed.
   b) Delay of about 9 usec (High range).
   c) Delay of about 2 usec (Med. range).
   d) Delay of about 0.4 usec (Low range).

4) The AVX-D-2 delay can be calibrated by means of a real time scope monitoring the time delay between the IN (or TRIG) and OUT ports.

MODEL AVX-D-2

LONG TERM DRIFT TEST ARRANGEMENT



Following a warm-up period of 5 minutes, the AVX-D-2 delay is constant within ±2 nsec.

03.29.85